

## Product Summary

Device	$V_{(BR)DSS}$	$R_{DS(ON) \max}$	$I_D \max$ $T_A = 25^\circ\text{C}$
Q1	20V	0.5Ω @ $V_{GS} = 4.5\text{V}$	1030mA
		0.9Ω @ $V_{GS} = 1.8\text{V}$	740mA
Q2	-20V	1.0Ω @ $V_{GS} = -4.5\text{V}$	-700mA
		2.0Ω @ $V_{GS} = -1.8\text{V}$	-460mA

## Description and Applications

This new generation MOSFET has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

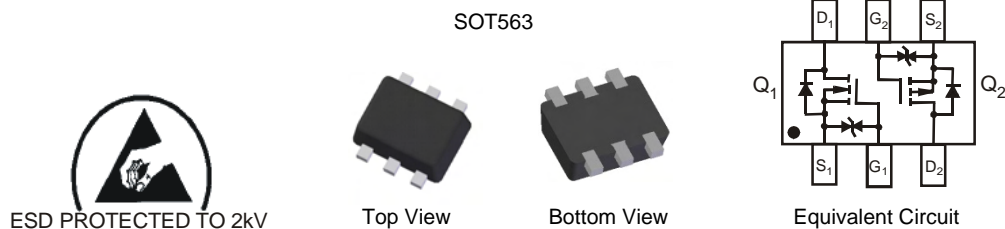
- Power management functions
- Battery Operated Systems and Solid-State Relays
- Load switch

## Features and Benefits

- Low On-Resistance
- Low Gate Threshold Voltage  $V_{GS(th)} < 1\text{V}$
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Ultra-Small Surface Mount Package
- **ESD Protected Gate to 2kV HBM**
- **Lead Free/RoHS Compliant (Note 1)**
- **"Green" Device, Halogen and Antimony Free (Note 2)**
- **Qualified to AEC-Q101 Standards for High Reliability**

## Mechanical Data

- Case: SOT563
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.003 grams (approximate)

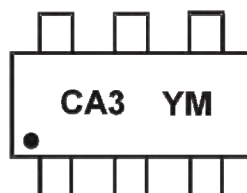


## Ordering Information (Note 3)

Part Number	Case	Packaging
DMC2400UV-7	SOT563	3000/Tape & Reel
DMC2400UV-13	SOT563	10000/Tape & Reel

- Notes:
1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. No purposely added lead. Halogen and Antimony free
  2. Diodes Inc.'s "Green" policy can be found on our website at <http://www.diodes.com>.
  3. For packaging details, go to our website at <http://www.diodes.com>.

## Marking Information



CA3 = Product Type Marking Code  
 YM = Date Code Marking  
 Y = Year (ex: Y = 2011)  
 M = Month (ex: 9 = September)

### Date Code Key

Year	2011	2012	2013	2014	2015	2016	2017
Code	Y	Z	A	B	C	D	E

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

**Maximum Ratings - Q1 N-CHANNEL** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	20	V
Gate-Source Voltage			$V_{GSS}$	$\pm 12$	V
Continuous Drain Current (Note 5) $V_{GS} = 4.5\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	1030 800	mA
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	1150 900	mA
Continuous Drain Current (Note 5) $V_{GS} = 1.8\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	740 570	mA
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	870 700	mA
Pulsed Drain Current (10 $\mu\text{s}$ pulse, duty cycle = 1%)			$I_{DM}$	3	A
Maximum Body Diode continuous Current			$I_S$	800	mA

**Maximum Ratings - Q2 P-CHANNEL** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	-20	V
Gate-Source Voltage			$V_{GSS}$	$\pm 8$	V
Continuous Drain Current (Note 5) $V_{GS} = -4.5\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	-700 -550	mA
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	-820 -640	mA
Continuous Drain Current (Note 5) $V_{GS} = -1.8\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	-460 -350	mA
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	-550 -420	mA
Pulsed Drain Current (10 $\mu\text{s}$ pulse, duty cycle = 1%)			$I_{DM}$	-2	A
Maximum Body Diode continuous Current			$I_S$	-800	mA

**Thermal Characteristics** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 4)		$P_D$	0.45	W
Thermal Resistance, Junction to Ambient (Note 4)	Steady state	$R_{\theta JA}$	281	$^\circ\text{C/W}$
	$t < 10\text{s}$		210	$^\circ\text{C/W}$
Total Power Dissipation (Note 5)		$P_D$	1	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	$R_{\theta JA}$	129	$^\circ\text{C/W}$
	$t < 10\text{s}$		97	$^\circ\text{C/W}$
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics - Q1 N-CHANNEL** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 6)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	20	-	-	V	$V_{GS} = 0V, I_D = 1mA$
Zero Gate Voltage Drain Current $T_J = 25^\circ\text{C}$	$I_{DSS}$	-	-	100	nA	$V_{DS} = 20V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	-	-	$\pm 1$	$\mu A$	$V_{GS} = \pm 5V, V_{DS} = 0V$
		-	-	$\pm 4.0$		$V_{GS} = \pm 8V, V_{DS} = 0V$
<b>ON CHARACTERISTICS (Note 6)</b>						
Gate Threshold Voltage	$V_{GS(th)}$	0.5	-	0.9	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
Static Drain-Source On-Resistance	$R_{DS(on)}$	-	0.3	0.48	$\Omega$	$V_{GS} = 5.0V, I_D = 200mA$
		-	0.35	0.5		$V_{GS} = 4.5V, I_D = 200mA$
		-	0.45	0.7		$V_{GS} = 2.5V, I_D = 200mA$
		-	0.55	0.9		$V_{GS} = 1.8V, I_D = 100mA$
		-	0.65	1.5		$V_{GS} = 1.5V, I_D = 50mA$
		-	2	-		$V_{GS} = 1.2V, I_D = 1mA$
		-	-	-		-
Forward Transfer Admittance	$ Y_{fs} $	-	1.4	-	S	$V_{DS} = 3V, I_D = 200mA$
Diode Forward Voltage	$V_{SD}$	-	0.7	1.2	V	$V_{GS} = 0V, I_S = 500mA$
<b>DYNAMIC CHARACTERISTICS (Note 7)</b>						
Input Capacitance	$C_{iss}$	-	37.1	-	pF	$V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz$
Output Capacitance	$C_{oss}$	-	6.5	-		
Reverse Transfer Capacitance	$C_{rss}$	-	4.8	-		
Gate Resistance	$R_g$	-	68	-	$\Omega$	$V_{DS} = 0V, V_{GS} = 0V$
Total Gate Charge	$Q_g$	-	0.5	-	nC	$V_{GS} = 4.5V, V_{DS} = 10V, I_D = 250mA$
Gate-Source Charge	$Q_{gs}$	-	0.07	-		
Gate-Drain Charge	$Q_{gd}$	-	0.1	-		
Turn-On Delay Time	$t_{D(on)}$	-	4.06	-	ns	$V_{DD} = 10V, V_{GS} = 4.5V, R_L = 47\Omega, R_G = 10\Omega, I_D = 200mA$
Turn-On Rise Time	$t_r$	-	7.28	-		
Turn-Off Delay Time	$t_{D(off)}$	-	13.74	-		
Turn-Off Fall Time	$t_f$	-	10.54	-		
		-		-		

- Notes:
4. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
  5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
  6. Short duration pulse test used to minimize self-heating effect.
  7. Guaranteed by design. Not subject to product testing.

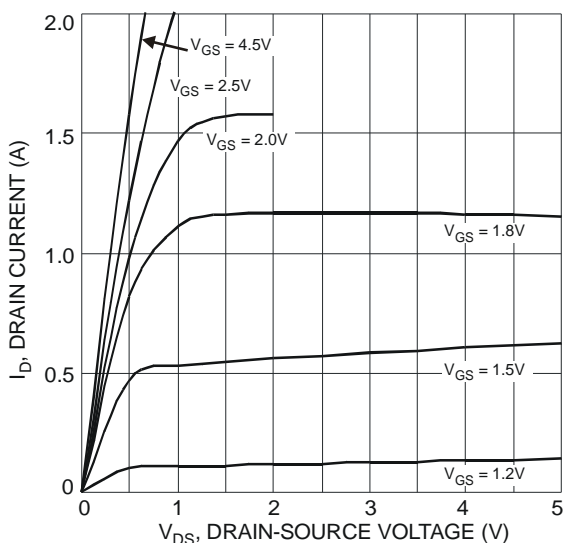


Fig. 1 Typical Output Characteristics

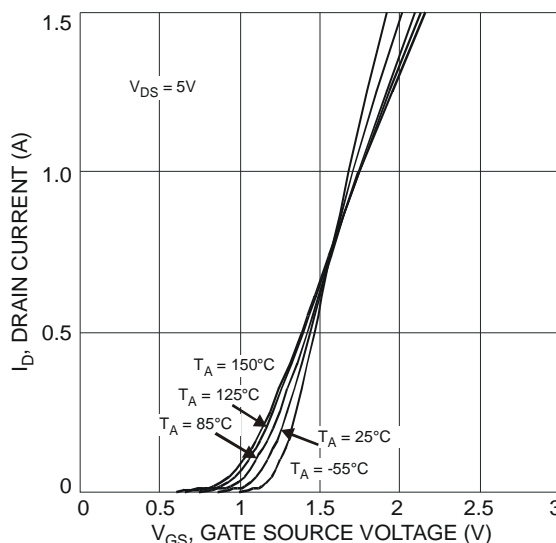


Fig. 2 Typical Transfer Characteristics

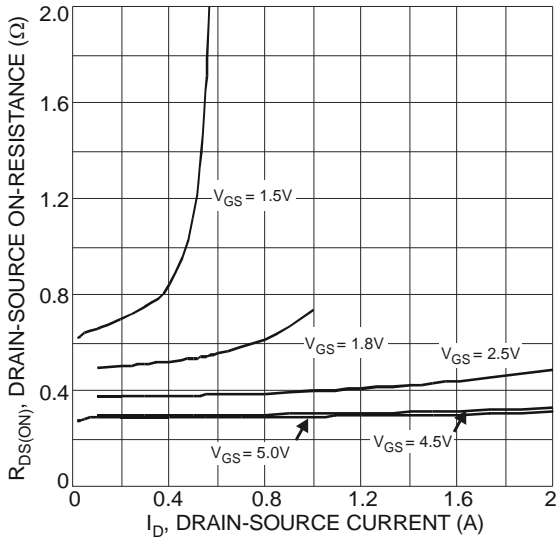


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

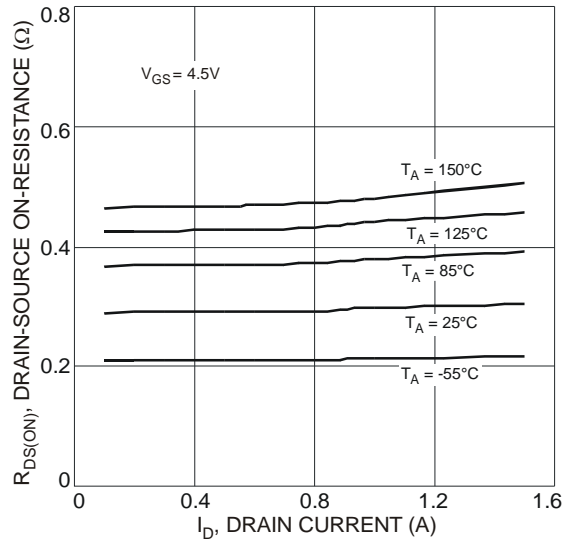


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

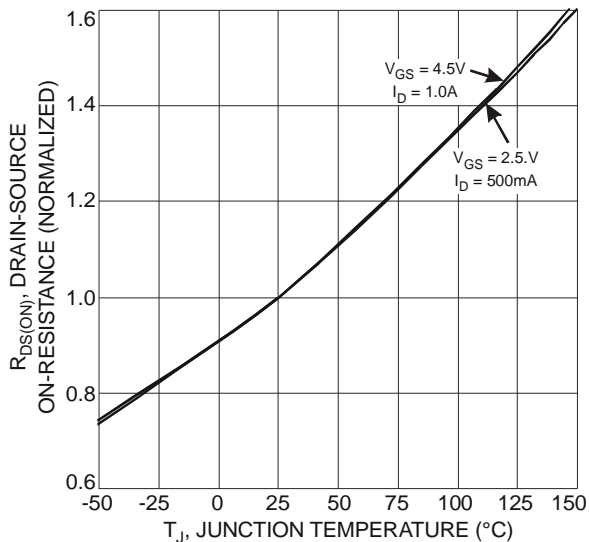


Fig. 5 On-Resistance Variation with Temperature

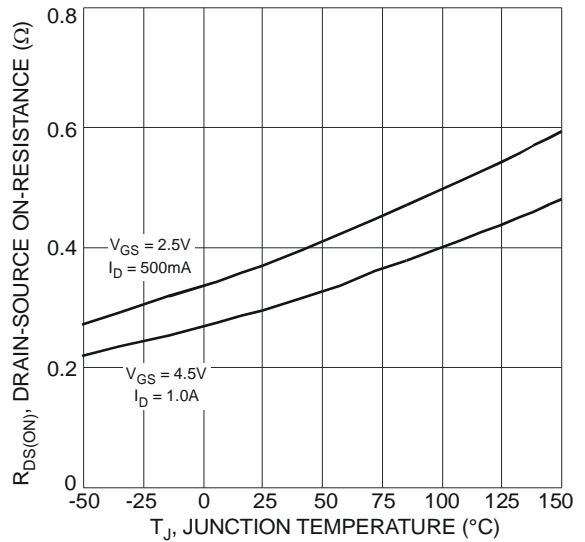


Fig. 6 On-Resistance Variation with Temperature

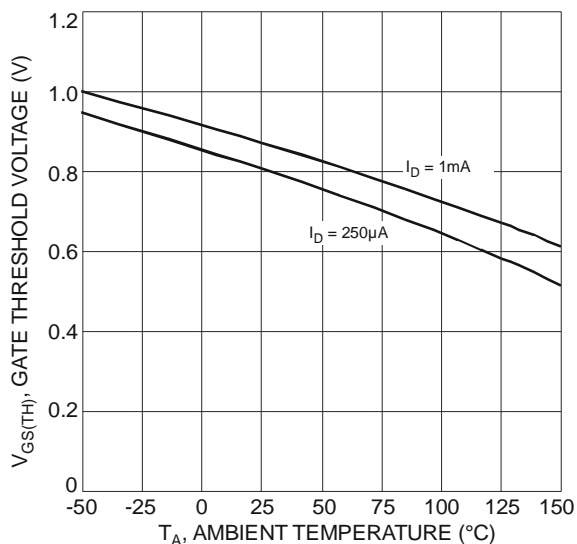


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

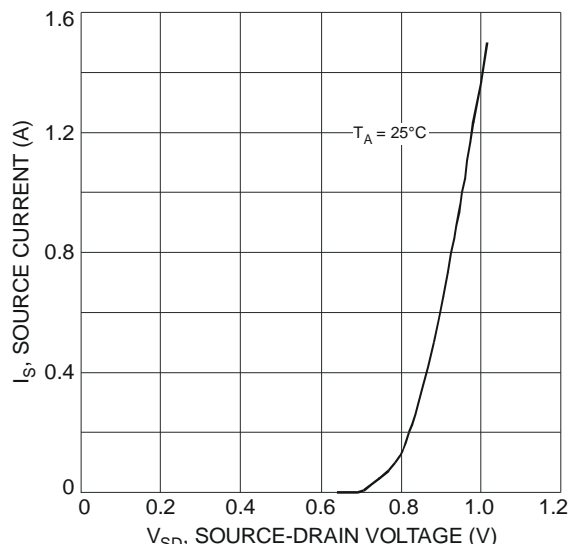
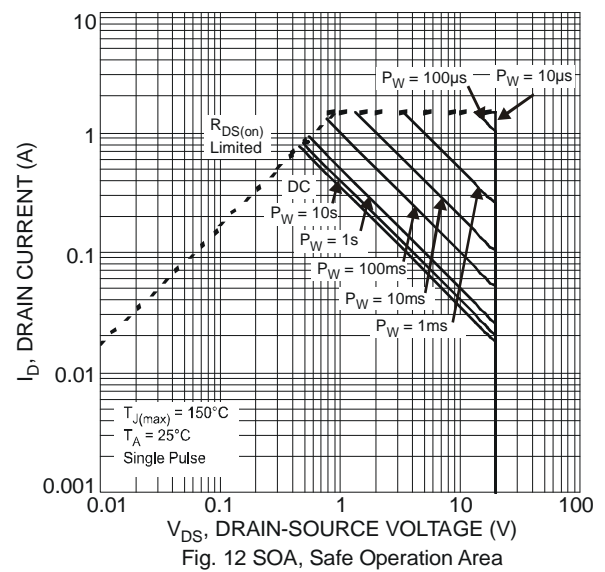
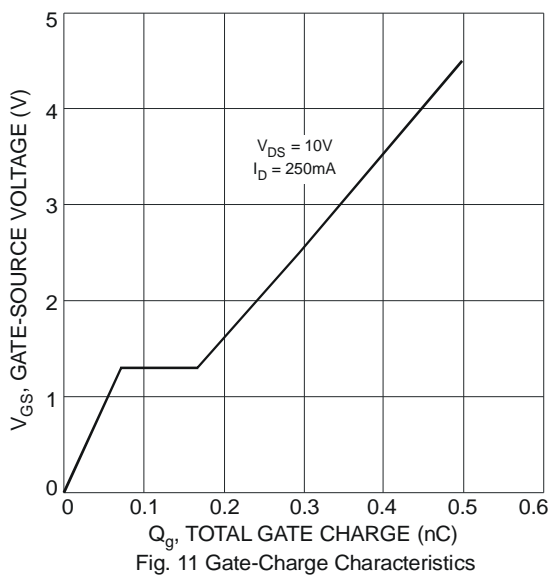
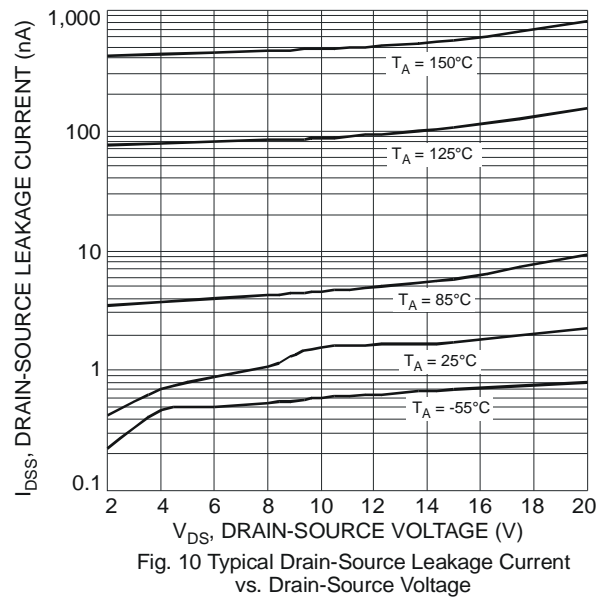
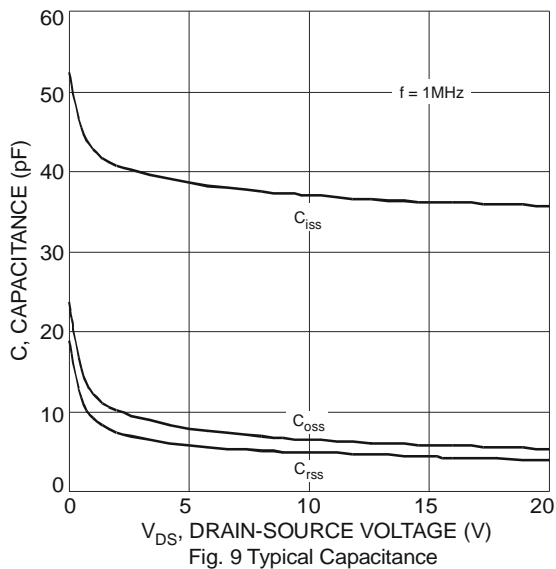


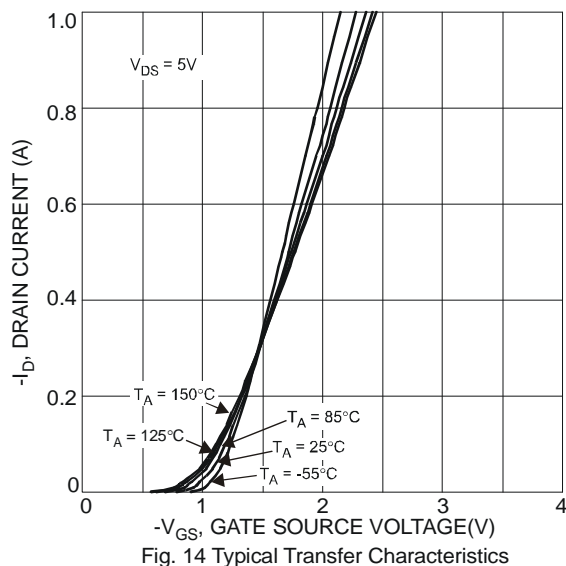
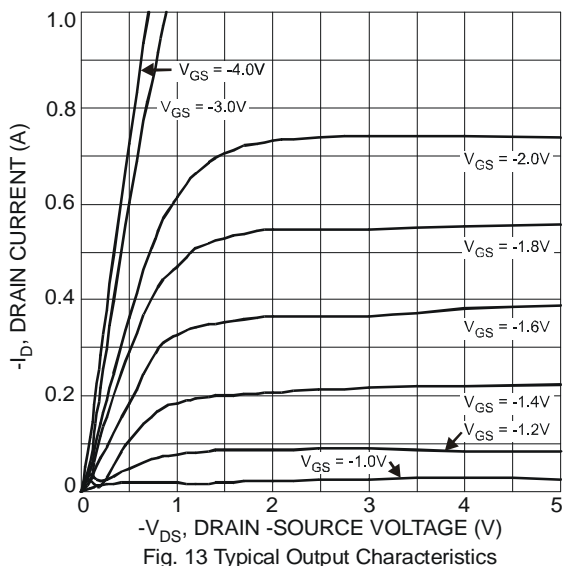
Fig. 8 Diode Forward Voltage vs. Current



**Electrical Characteristics - Q2 P-CHANNEL** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 6)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	-20	-	-	V	$V_{GS} = 0V, I_D = -1mA$
Zero Gate Voltage Drain Current $T_J = 25^\circ\text{C}$	$I_{DSS}$	-	-	-100	nA	$V_{DS} = -20V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	-	-	$\pm 1.0$	$\mu\text{A}$	$V_{GS} = \pm 5V, V_{DS} = 0V$
		-	-	$\pm 5.0$		$V_{GS} = \pm 8V, V_{DS} = 0V$
<b>ON CHARACTERISTICS (Note 6)</b>						
Gate Threshold Voltage	$V_{GS(th)}$	-0.5	-	-1.0	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(on)}$	-	0.67	0.97	$\Omega$	$V_{GS} = -5V, I_D = -100mA$
		-	0.7	1.0		$V_{GS} = -4.5V, I_D = -100mA$
		-	0.9	1.5		$V_{GS} = -2.5V, I_D = -80mA$
		-	1.2	2.0		$V_{GS} = -1.8V, I_D = -40mA$
		-	1.5	3.0		$V_{GS} = -1.5V, I_D = -30mA$
		-	5	-		$V_{GS} = -1.2V, I_D = -1mA$
Forward Transfer Admittance	$ Y_{fs} $	-	0.7	-	S	$V_{DS} = -3V, I_D = -100mA$
Diode Forward Voltage	$V_{SD}$	-	-0.75	-1.2	V	$V_{GS} = 0V, I_S = -330mA$
<b>DYNAMIC CHARACTERISTICS (Note 7)</b>						
Input Capacitance	$C_{iss}$	-	46.1	-	pF	$V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz$
Output Capacitance	$C_{oss}$	-	7.2	-		
Reverse Transfer Capacitance	$C_{rss}$	-	4.9	-		
Gate Resistance	$R_g$	-	14.3	-	$\Omega$	$V_{DS} = 0V, V_{GS} = 0V,$
Total Gate Charge $V_{GS} = -4.5V$	$Q_g$	-	0.5	-	nC	$V_{DS} = -10V, I_D = -250mA$
Total Gate Charge $V_{GS} = -10V$	$Q_g$	-	0.85	-		
Gate-Source Charge	$Q_{gs}$	-	0.09	-		
Gate-Drain Charge	$Q_{gd}$	-	0.09	-		
Turn-On Delay Time	$t_{D(on)}$	-	8.5	-	ns	$V_{DD} = -3V, V_{GS} = -2.5V, R_L = 300\Omega, R_G = 25\Omega, I_D = -100mA$
Turn-On Rise Time	$t_r$	-	4.3	-		
Turn-Off Delay Time	$t_{D(off)}$	-	20.2	-		
Turn-Off Fall Time	$t_f$	-	19.2	-		

- Notes: 4. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.  
 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.  
 6. Short duration pulse test used to minimize self-heating effect.  
 7. Guaranteed by design. Not subject to product testing.



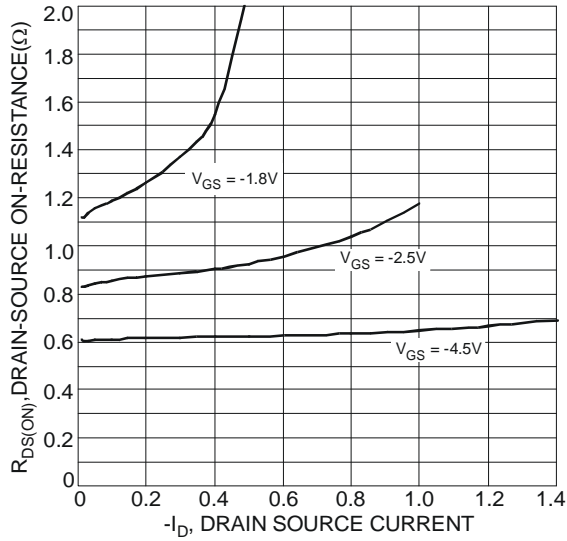


Fig. 15 Typical On-Resistance vs. Drain Current and Gate Voltage

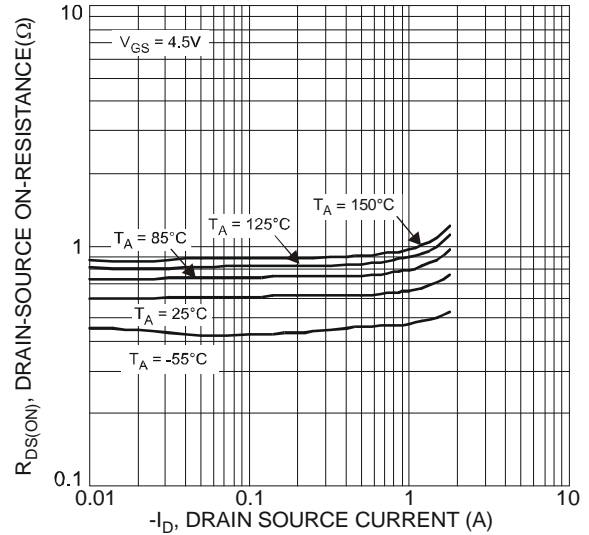


Fig. 16 Typical On-Resistance vs. Drain Current and Temperature

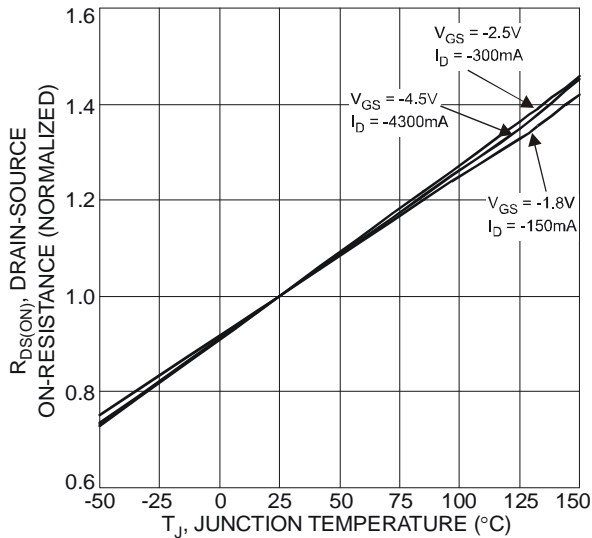


Fig. 17 On-Resistance Variation with Temperature

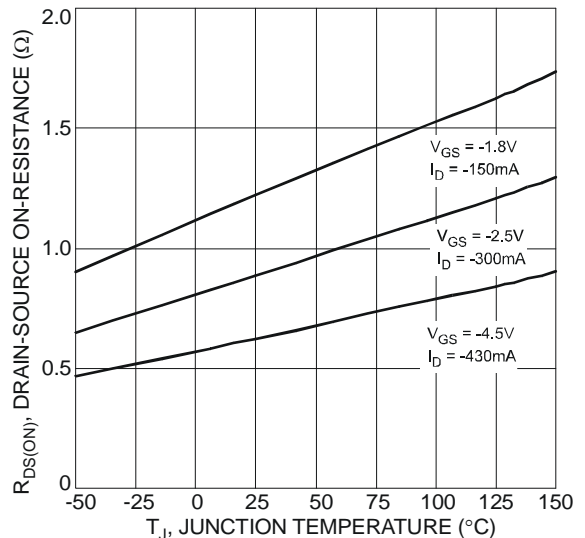


Fig. 18 On-Resistance vs. Temperature

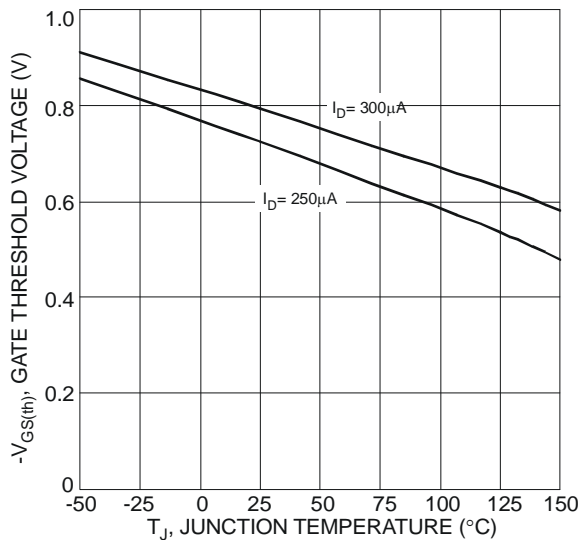


Fig. 19 Gate Threshold Variation vs. Ambient Temperature

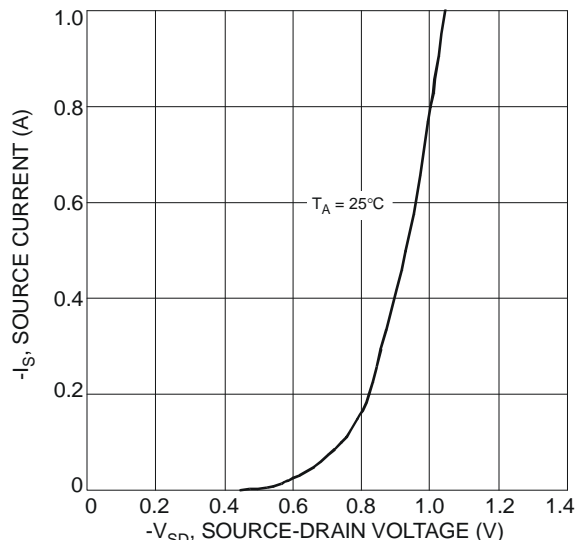


Fig. 20 Diode Forward Voltage vs. Current

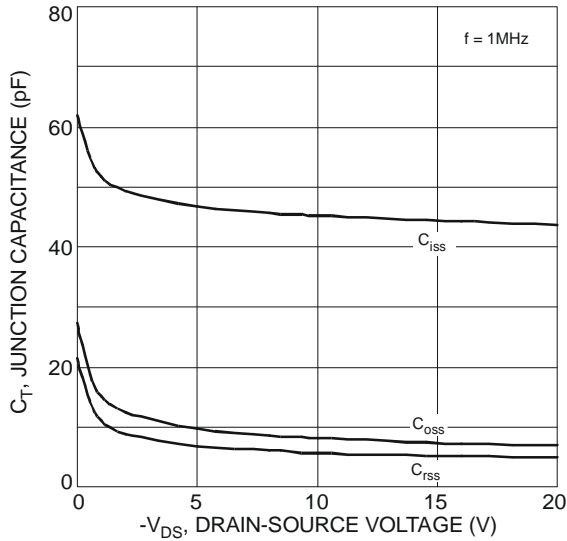


Fig. 21 Typical Junction Capacitance

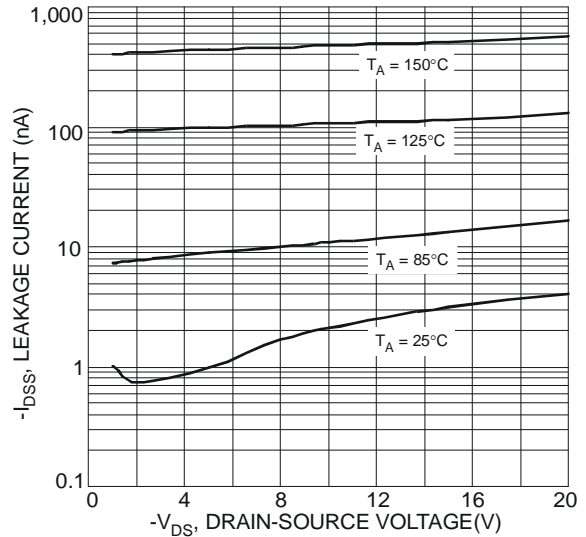


Fig. 22 Typical Drain-Source Leakage Current vs. Voltage

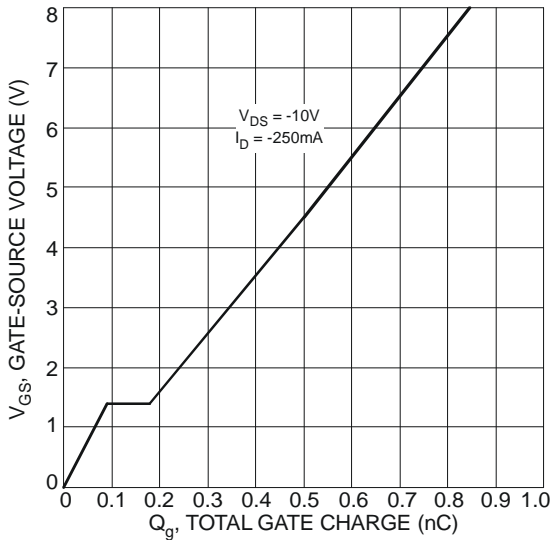


Fig. 23 Gate-Charge Characteristics

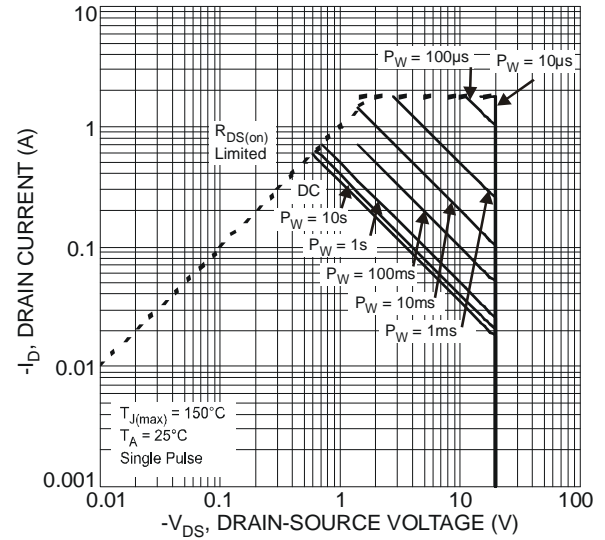


Fig. 24 SOA, Safe Operation Area

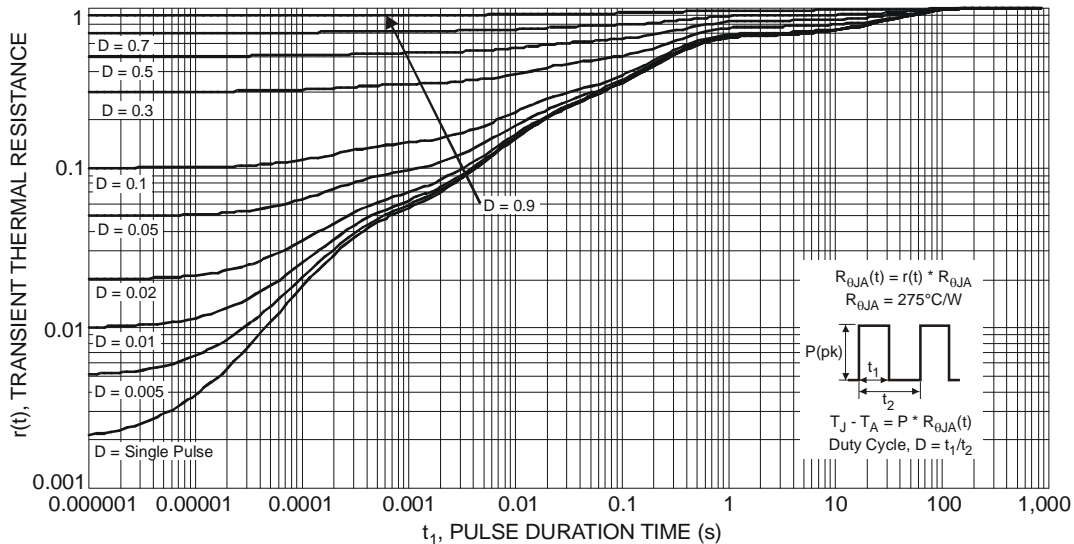
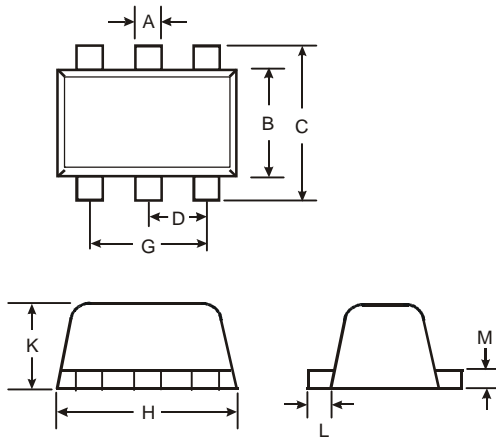


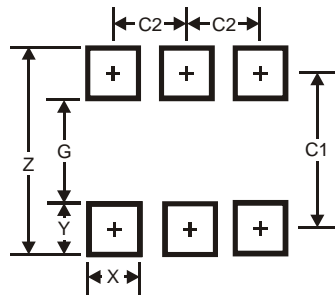
Fig. 25 Transient Thermal Response

**Package Outline Dimensions**



SOT563			
Dim	Min	Max	Typ
A	0.15	0.30	0.20
B	1.10	1.25	1.20
C	1.55	1.70	1.60
D	-	-	0.50
G	0.90	1.10	1.00
H	1.50	1.70	1.60
K	0.55	0.60	0.60
L	0.10	0.30	0.20
M	0.10	0.18	0.11
All Dimensions in mm			

**Suggested Pad Layout**



Dimensions	Value (in mm)
Z	2.2
G	1.2
X	0.375
Y	0.5
C1	1.7
C2	0.5

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Электрон  
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